

# Computation of tightly-focused laser beams in the FDTD method

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**Abstract:** We demonstrate how a tightly-focused coherent  $\text{TEM}_{mn}$  laser beam can be computed in the finite-difference time-domain (FDTD) method. The electromagnetic field around the focus is decomposed into a plane-wave spectrum, and approximated by a finite number of plane waves injected into the FDTD grid using the total-field/scattered-field (TF/SF) method. We provide an error analysis, and guidelines for the discrete approximation. We analyze the scattering of the beam from layered spaces and individual scatterers. The described method should be useful for the simulation of confocal microscopy and optical data storage. An implementation of the method can be found in our free and open source FDTD software (“Angora”).

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## References and links

1. A. Taflove and S. C. Hagness, *Computational Electrodynamics: The Finite-Difference Time-Domain Method* (Artech House, Boston, 2005), 3rd ed.
2. W. Sun, S. Pan, and Y. Jiang, “Computation of the optical trapping force on small particles illuminated with a focused light beam using a FDTD method,” *J. Mod. Opt.* **2691–2700** (2006).
3. I. R. Capoglu, A. Taflove, and V. Backman, “Generation of an incident focused light pulse in FDTD,” *Opt. Express* **16**, 19208–19220 (2008).
4. L. Jia and E. L. Thomas, “Radiation forces on dielectric and absorbing particles studied via the finite-difference time-domain method,” *J. Opt. Soc. Am. B Opt. Phys.* **26**, 1882–1891 (2009).
5. J. Lin, F. Lu, H. Wang, W. Zheng, C. J. R. Sheppard, and Z. Huang, “Improved contrast radially polarized coherent anti-Stokes Raman scattering microscopy using annular aperture detection,” *Appl. Phys. Lett.* **95** (2009).
6. C. Guiffaut and K. Mahdjoubi, “A perfect wideband plane wave injector for FDTD method,” in “Antennas and Propagation Society International Symposium, 2000. IEEE.”, (Salt Lake City, UT, USA, 2000), **1**, 236–239.
7. T. Tan and M. Potter, “FDTD discrete planewave (FDTD-DPW) formulation for a perfectly matched source in TFSF simulations,” *IEEE Trans. Antennas Propag.* **58**, 2641–2648 (2010).
8. L. Mandel and E. Wolf, *Optical Coherence and Quantum Optics* (Cambridge University Press, 1995).
9. M. Abramowitz and I. A. Stegun, eds., *Handbook of Mathematical Functions with Formulas, Graphs, and Mathematical Tables* (U.S. Govt. Print. Off., 1964).
10. J. W. Goodman, *Statistical Optics* (Wiley, New York, NY, 2000).
11. M. Born and E. Wolf, *Principles of Optics : Electromagnetic Theory of Propagation, Interference and Diffraction of Light* (Cambridge University Press, Cambridge, 1999), 7th ed.
12. L. Novotny and B. Hecht, *Principles of Nano-optics* (Cambridge University Press, 2006).
13. B. Richards and E. Wolf, “Electromagnetic diffraction in optical systems. II. Structure of the image field in an aplanatic system,” *Proc. R. Soc. Lond. A Math. Phys. Sci.* **253**, 358–379 (1959).
14. E. Wolf, “Electromagnetic diffraction in optical systems. I. An integral representation of the image field,” *Proc. R. Soc. Lond. A Math. Phys. Sci.* **253**, 349–357 (1959).

15. M. Born and E. Wolf, *Principles of Optics* (Cambridge University Press, Cambridge, 1999), 7th ed.
16. R. Cools and K. Kim, "A survey of known and new cubature formulas for the unit disk," *J. Appl. Math. Comput.* **7**, 477–485 (2000).
17. R. Cools and P. Rabinowitz, "Monomial cubature rules since Stroud: A compilation," *J. Comput. Appl. Math.* **48**, 309–326 (1993).
18. R. Cools, "Monomial cubature rules since Stroud: A compilation - part 2," *J. Comput. Appl. Math.* **112**, 21–27 (1999).
19. R. Cools, "An encyclopaedia of cubature formulas," *J. Complexity* **19**, 445–453 (2003).
20. L. E. R. Petersson and G. S. Smith, "On the use of a Gaussian beam to isolate the edge scattering from a plate of finite size," *IEEE Trans. Antennas Propag.* **52**, 505–512 (2004).
21. W. H. Press, B. P. Flannery, S. A. Teukolsky, and W. T. Vetterling, *Numerical Recipes: The Art of Scientific Computing* (Cambridge University Press, Cambridge, 1986).
22. R. Cools, "Encyclopaedia of Cubature Formulas," (2012). <http://nines.cs.kuleuven.be/ecf>.
23. L. Novotny, Private communication.
24. I. R. Capoglu and G. S. Smith, "A total-field/scattered-field plane-wave source for the FDTD analysis of layered media," *IEEE Trans. Antennas Propag.* **56**, 158–169 (2008).
25. I. R. Capoglu, A. Taflove, and V. Backman, "A frequency-domain near-field-to-far-field transform for planar layered media," *IEEE Trans. Antennas Propag.* **60**, 1878–1885 (2012).
26. J. A. Roden and S. D. Gedney, "Convolution PML (CPML): an efficient FDTD implementation of the CFD-PML for arbitrary media," *Microw. Opt. Technol. Lett.* **27**, 334–9 (2000).
27. I. R. Capoglu, J. D. Rogers, A. Taflove, and V. Backman, "Chapter 1 - The Microscope in a Computer: Image Synthesis from Three-Dimensional Full-Vector Solutions of Maxwell's Equations at the Nanometer Scale," in *Progress in Optics*, E. Wolf, ed. (Elsevier, 2012), **57**, 1–91.
28. I. R. Capoglu, "Angora: A free software package for finite-difference time-domain (FDTD) electromagnetic simulation," (2012). <http://www.angorafDTD.org>.
29. I. R. Capoglu, A. Taflove, and V. Backman, "Angora: A free software package for finite-difference time-domain electromagnetic simulation," accepted for publication in the *IEEE Antennas and Propagation Magazine*.
30. I. R. Capoglu, "Binaries and configuration files used for the manuscript "Computation of tightly-focused laser beams in the FDTD method"," (2012). <http://www.angorafDTD.org/ext/tflb/>.

## 1. Introduction

The finite-difference time-domain (FDTD) numerical electromagnetic method [1] is gaining increasing popularity for solving nano-photonics problems [2–5]. In the FDTD method, the electromagnetic field is defined at a finite number of discrete spatial positions, and calculated at consecutive discrete time instants using an explicit leapfrogging algorithm. The simplest illumination modality in the FDTD method is the plane wave, which is now a standard feature in most FDTD implementations. However, in many optical situations one needs to simulate a more complicated illumination beam. In this paper, we describe how a transverse-electric-magnetic (TEM) laser mode of order  $(m, n)$  focused by a lens can be simulated in the FDTD method. The basis of our technique is the decomposition of the beam around the focus into a plane-wave spectrum, and the representation of this infinite sum by a finite number of plane waves with suitable amplitude factors. Each plane wave is introduced into the FDTD computational grid using the total-field/scattered-field (TF/SF) method, which is well-studied in the literature. The traditional TF/SF approach for injecting a plane wave into the FDTD grid, explained in detail in [1], has since been refined by numerous authors. Two notable improvements to the TF/SF method are the matched-numerical-dispersion method [6] and the perfectly-matched plane-wave source method [7].

The approach described in this paper is similar to that followed in our previous work [3], with the following improvements: (i) The range of beams that can be introduced into the FDTD grid is significantly expanded. The results in [3] merely correspond to the  $(0, 0)$  mode with  $f_0 = \infty$  within the context of the present paper. (ii) The focused beam is computed in spaces with planar layers and inhomogeneities. A microscopy example is given to demonstrate the possibility for simulating a confocal imaging scenario. (iii) The error analysis performed in the present paper is much more comprehensive and general. (iv) The results described here have been implemented

in an open-source FDTD software (*Angora*), which can be freely downloaded under the GNU Public License.

The rest of the paper is organized as follows. In Section 2, the theory of the focused laser beam is explained. In Section 3, the FDTD computation of the theoretical results in Section 2 are given. In Section 4, a comparative error analysis is presented for various approximation schemes. In Section 5, planar layered spaces and scatterers are discussed, and the capability for simulating confocal microscopy is demonstrated. In Section 6, future directions are discussed. In Section 7, our free, open-source FDTD software (*Angora*) is briefly introduced. The paper is concluded by final remarks in Section 8.

## 2. Focusing of laser beams

The transverse-electric-magnetic laser mode of order  $(m, n)$  (also called a Hermite-Gaussian mode, or a  $\text{TEM}_{mn}$  mode) is a solution of the paraxial wave equation [8], which assumes that the energy in the beam propagates mainly in a single direction along parallel rays. The electric field of a  $\text{TEM}_{mn}$  mode at the beam waist, which is assumed to lie in the  $(x, y)$  plane, is given by the following expression:

$$\mathbf{E}_{\text{inc}}(x, y; t) = \hat{\mathbf{e}} \psi(t) \gamma_{mn}(x, y) = \hat{\mathbf{e}} \psi(t) H_m(\sqrt{2}x/w_0) H_n(\sqrt{2}y/w_0) e^{-(x^2+y^2)/w_0^2}, \quad (1)$$

where  $\hat{\mathbf{e}}$  is the constant transverse unit vector in the  $(x, y)$  plane that determines the uniform polarization,  $\psi(t)$  is the time waveform of the beam,  $w_0$  is the beam width, and  $H_n(x)$  are the  $n^{\text{th}}$ -order Hermite polynomials [9]. The first two Hermite polynomials are  $H_0(x) = 1$ ,  $H_1(x) = 2x$ . The intensity maps of the the time-independent parts of the  $(0, 0)$ ,  $(0, 1)$ ,  $(1, 0)$ , and  $(1, 1)$  modes on the beam waist are shown in Fig. 1(a). In real situations, the time dependence  $\psi(t)$  is a randomly-fluctuating waveform; which can be assumed statistically stationary in time [8]. This random process will have a wavelength spectrum, which might consist merely of a very narrow wavelength band for a traditional laser, or span a wide range of wavelengths for a supercontinuum laser. If the entire optical system (including the illuminated object) is linear and time invariant, all second-order coherence properties at the output (e.g., power-spectral density at a point, mutual coherence function between two points, etc.) are completely determined by the second-order coherence properties of the input waveform and the deterministic spectral response of the system [8, 10, 11]. The latter can be obtained by sending a deterministic time pulse with a finite duration and a predefined spectral content through the system. The parameters of a modulated Gaussian waveform, for example, can easily be adjusted to manipulate its spectral content; since the cutoff wavelengths of this waveform are expressible in closed form. This is a suitable approach for a deterministic numerical method such as FDTD that operates directly in time domain.

If the maximum appreciable free-space wavelength  $\lambda_{\text{max}}$  present in the spectrum of  $\psi(t)$  is *much smaller* than the beam waist  $w_0$ , the paraxial approximation becomes valid, and the rays in the beam stay mostly parallel to the  $z$  axis beyond the beam waist for many beam widths [12]. We assume that such a highly-paraxial beam is incident on the entrance pupil of a positive (convergent) optical system, as shown in Fig. 1(b). The focusing system is assumed to be free of spherical aberration and obeying the Abbe sine condition. In other words, all parallel rays entering the entrance pupil are focused at the back focal point  $F$ , and  $a = f \sin \theta_{\text{ill}}$ ; where  $a$  is the radius of the pupil,  $f$  is the back focal length of the system, and  $\theta_{\text{ill}}$  is the illumination aperture angle. A portion of the Gaussian reference sphere around  $F$  is shown shaded in Fig. 1(b). The object and image spaces of the focusing system are non-magnetic ( $\mu_1=\mu_2=1$ ) with refractive indices  $n_1$  and  $n_2$ , respectively. An example ray converging toward  $F$  is shown in Fig. 1(b). The ray makes an angle  $\theta$  with the optical axis at  $F$ . In the geometrical optics regime, the

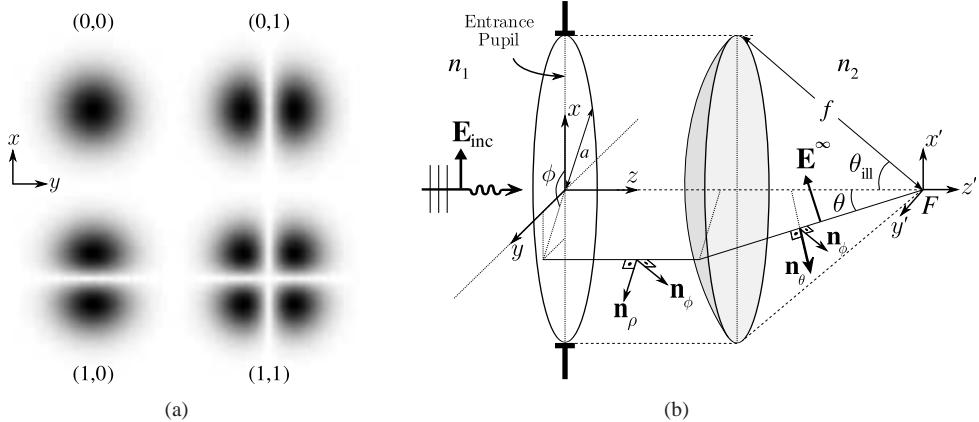


Fig. 1. (a) Intensity maps of several  $\text{TEM}_{mn}$  modes on the beam waist. (b) The geometry of the incidence and focusing of the beam.

electric field  $\mathbf{E}^\infty$  on the ray is in the form

$$\mathbf{E}^\infty(r, \theta, \phi, t) = \hat{\mathbf{a}}(\theta, \phi) E^\infty(\theta, \phi, t + n_2 r/c)/r, \quad (2)$$

where  $\hat{\mathbf{a}}$  is the unit vector specifying the polarization, and  $E^\infty(\theta, \phi, t)$  is the *strength factor* of the ray [13]. The combined electric field around the focus  $F$  due to all the incoming rays is given by the Debye-Wolf diffraction integral [13]:

$$\mathbf{E}(\mathbf{r}', t) = \frac{n_2}{2\pi c} \iint_{\Omega_{\text{ill}}} \hat{\mathbf{a}}(\theta, \phi) \dot{E}^\infty(\theta, \phi, t - n_2 \hat{\mathbf{s}} \cdot \mathbf{r}'/c) d\Omega, \quad (3)$$

in which

$$\hat{\mathbf{s}} = (s_x, s_y, s_z) = (-\sin \theta \cos \phi, -\sin \theta \sin \phi, \cos \theta) \quad (4)$$

$$\mathbf{r}' = (x', y', z') \quad (5)$$

are the incidence unit vector and the position vector in the image space,  $\Omega_{\text{ill}}$  is the conical solid angle bounded by  $\theta_{\text{ill}}$ , and  $d\Omega = \sin \theta d\theta d\phi = ds_x ds_y / \cos \theta$ . The dot above  $E^\infty$  denotes the derivative with respect to time. The strength factor  $E^\infty(\theta, \phi, t)$  can be related to the Hermite-Gaussian beam on the entrance pupil using geometrical optics principles [12–14]:

$$E^\infty(\theta, \phi, t) = (n_1/n_2)^{1/2} f \cos^{1/2}(\theta) \psi(t - t_c) \gamma_{mn}(x, y), \quad (6)$$

where  $\gamma_{mn}(x, y)$  is the Hermite-Gaussian beam profile defined in Eq. (1). The delay  $t_c$  in the time waveform  $\psi(t)$  represents the time of propagation for any ray from the entrance pupil to  $F$ . Since all wavefronts converge at  $F$ , this delay is independent of  $\theta$  and  $\phi$ ; so the definition of  $\psi(t)$  can be time-advanced to cancel  $t_c$ . The relationship between the coordinates  $(x, y)$  and  $(\theta, \phi)$  in the object and image spaces follows from the Abbe sine condition:  $(x, y) = (f \sin \theta \cos \phi, f \sin \theta \sin \phi)$ . For small incidence angles at each refracting surface, the angle that  $\hat{\mathbf{a}}$  makes with the meridional plane (one defined by the ray and the optical axis) will be the same as that of  $\hat{\mathbf{e}}$  [13, 15]. Therefore we have  $\hat{\mathbf{a}} \cdot \mathbf{n}_\theta = \hat{\mathbf{e}} \cdot \mathbf{n}_\rho$  and  $\hat{\mathbf{a}} \cdot \mathbf{n}_\phi = \hat{\mathbf{e}} \cdot \mathbf{n}_\phi$ , where the unit vectors  $\mathbf{n}_\theta$ ,  $\mathbf{n}_\rho$ ,  $\mathbf{n}_\phi$  are as shown in Fig. 1(b).

We assume that the entrance pupil of the optical system not overfilled; namely, the beam width  $w_0$  is sufficiently smaller than the pupil radius  $a$  so that the beam is contained within the pupil. Following [12], we define the *filling factor* as the following ratio:

$$f_0 = w_0/a = w_0/(f \sin \theta_{\text{ill}}) \quad (7)$$

In the remainder of this analysis, we assume that the filling factor  $f_0$  is less than 0.6. Increasing  $f_0$  beyond this number causes the focal fields to have a more oscillatory behavior, which makes the approximation methods introduced here less accurate. A more uniform method of approximation that is valid for all values of  $f_0$  is the subject of future study.

The results in Eqs. (1)–(6) express the electromagnetic field around the focus  $F$  for a paraxial incoming beam  $\mathbf{E}_{\text{inc}}$  at the entrance pupil. In the following section, we will show how this formulation can be discretized and adapted to the FDTD numerical method.

### 3. FDTD implementation using the TF/SF method

Upon inspection, it is seen that the diffraction integral in Eq. (3) is an infinite summation of plane waves, each traveling in a different direction determined by  $\hat{\mathbf{s}}$ . Let's write the integral in Eq. (3) as a Riemann sum over a finite collection of plane waves:

$$\tilde{\mathbf{E}}(\mathbf{r}', t) = \frac{n_2}{2\pi c} \sum_n \alpha_n \hat{\mathbf{a}}(\theta_n, \phi_n) \dot{E}^\infty(\theta_n, \phi_n, t - n_2 \hat{\mathbf{s}}_n \cdot \mathbf{r}' / c), \quad (8)$$

in which the index  $n$  is used to enumerate the individual plane waves. The spherical incidence angles are  $\theta_n$  and  $\phi_n$ , and the incidence directions  $\hat{\mathbf{s}}_n$  are

$$\hat{\mathbf{s}}_n = (s_{x_n}, s_{y_n}, s_{z_n}) = (-\sin \theta_n \cos \phi_n, -\sin \theta_n \sin \phi_n, \cos \theta_n). \quad (9)$$

The weight  $\alpha_n$  replaces the differential  $d\Omega$  in Eq. (3). The above form is not necessarily the optimal solution for the approximation of the focal fields, since the choice of  $\hat{\mathbf{s}}_n$  and  $\alpha_n$  are independent of the image-space position  $\mathbf{r}'$  and the time  $t$ . However, this arrangement has the advantage that the beam is expressed as a sum of plane waves, each of which can be introduced into the FDTD grid using well-documented approaches such as the scattered-field (SF) or the total-field/scattered-field (TF/SF) methods [1]. We have chosen the TF/SF method for our implementation, mainly because its computational cost is proportional to the surface area of the TF/SF boundary. The cost of the SF method is usually much higher, since it is proportional to the volume of the region over which the beam is calculated.

The Debye-Wolf diffraction integral in Eq. (3) is basically a two-dimensional integral over the direction cosines  $s_x, s_y$  inside the unit disk  $s_x^2 + s_y^2 < \sin^2 \theta_{\text{ill}}$ . The choice of the incidence directions  $\hat{\mathbf{s}}_n$  and the weights  $\alpha_n$  in Eq. (8) for the optimal approximation of Debye-Wolf diffraction integral in Eq. (3) is the subject of *two-dimensional cubature* [17–19]. In this paper, we consider three different approaches to this problem. These are explained in the following subsections.

#### 3.1. Equally-spaced $s_x, s_y$

The most straightforward way of placing the plane wave directions  $\hat{\mathbf{s}}_n$  inside the unit disk  $s_x^2 + s_y^2 < \sin^2 \theta_{\text{ill}}$  is an equally-spaced Cartesian arrangement shown in Fig. 2(a). The  $(s_x, s_y)$  points are spaced  $\Delta s_x$  and  $\Delta s_y$  apart in the  $s_x$  and  $s_y$  directions, respectively; with equal cubature weight  $\alpha_n = \Delta s_x \Delta s_y$  for each point. In addition to the simplicity of this arrangement, useful guidelines can be derived for the spacings  $\Delta s_x$  and  $\Delta s_y$ . These guidelines rely on the Whittaker-Shannon sampling theorem [20]. The principle behind this is best explained if harmonic time dependence

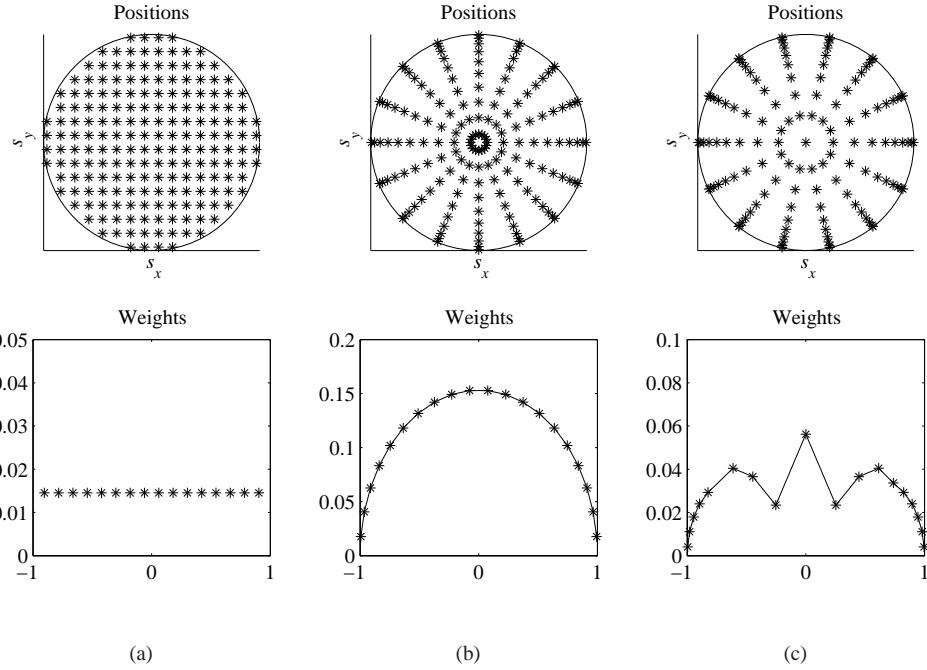


Fig. 2. Cubature rules for the approximation in Eq. (8) for the 2D integral in Eq. (3). The top graphs show the placement of the quadrature points in the unit disk. The bottom graphs show the weights along  $s_y=0$ . (a) 188 points on an equally-spaced Cartesian grid of  $(s_x, s_y)$  positions inside the illumination cone. (b) Separation of the 2D integral on the  $(s_x, s_y)$  plane into two 1D integrals over the radial coordinates  $(s, \phi)$ . The  $s$  integral is evaluated using Gauss-Legendre quadrature, and the  $\phi$  integral is evaluated using the midpoint rule. A total of  $20 \times 8 = 160$  quadrature points are used. (c) A custom 127-point quadrature rule for the unit disk [16], exact for polynomials  $s_x^i s_y^j$  where  $i + j < 25$ .

$\exp(-i\omega t)$  is assumed in the diffraction integral in Eq. (3):

$$\mathbf{E}(\mathbf{r}') = \frac{-ik'}{2\pi} \iint_{-\infty}^{\infty} P(s_x, s_y) \hat{\mathbf{a}}(\hat{\mathbf{s}}) E^{\infty}(\hat{\mathbf{s}}) e^{ik' \hat{\mathbf{s}} \cdot \mathbf{r}'} ds_x ds_y / \cos \theta , \quad (10)$$

in which  $k' = n_2 \omega / c$  is the wavenumber in the object space, and  $P(s_x, s_y)$  is equal to 1 for  $s_x^2 + s_y^2 < \sin^2 \theta_{\text{ill}}$ , and zero otherwise. For a fixed  $z'$ , the observation coordinate  $\mathbf{r}'$  depends only on  $x'$  and  $y'$ . The integral in Eq. (10) is then in the form of a two-dimensional *Fourier transform* from the  $(s_x, s_y)$  domain to the  $(x', y')$  domain. Since the center of the beam is usually the region of interest, we can proceed by taking  $z' = 0$ . The Whittaker-Shannon sampling theorem says that, if the integral in Eq. (10) is approximated by a finite sum at a Cartesian grid of  $(s_x, s_y)$  points as shown in Fig. 2(a), the result is an *infinitely replicated* (or *aliased*) version of  $\mathbf{E}(\mathbf{r}')$  [20]. Assuming  $\Delta s_x = \Delta s_y = \Delta$ , the period of this replication is given by

$$D = \frac{2\pi}{k' \Delta} \quad (11)$$

If the fields on the focal plane ( $z' = 0$ ) can be contained in a square region of dimensions  $W_0 \times W_0$ , an overlap can be avoided with  $D > W_0$ . From vectorial diffraction theory, we know

that the focal fields decay in the lateral direction at a distance scale of  $d_0 = \lambda / (n_2 f_0 \sin \theta_{\text{ill}})$  around the focus [12]. This holds as long as  $f_0$  is inside our range of interest  $0 < f_0 < 0.6$ . Our extensive numerical experiments suggest that the beam is always well contained within  $5d_0 - 6d_0$  of the focus. In our implementation, we choose  $W_0$  to be  $5.2d_0$ . Another length scale to be taken into account is the lateral size of the TF/SF boundary. If the TF/SF boundary is too wide, the beam may be replicated inside the boundary. If the lateral diagonal length of the TF/SF boundary is  $T_0$ ,  $D$  should be larger than  $T_0$  to avoid this replication. In summary, the condition on the spacing  $\Delta$  is

$$\Delta < \frac{2\pi}{k' \max\{W_0, T_0\}}. \quad (12)$$

In the following, we will denote this quadrature scheme by the acronym **EQ**.

### 3.2. Gauss-Legendre quadrature

The integral in Eq. (3) can be reduced into two nested one-dimensional integrals, and approximated using more familiar quadrature rules. First, the variables are changed from the Cartesian coordinates  $(s_x, s_y)$  into the radial coordinates  $(s, \phi)$ , where  $s = (s_x^2 + s_y^2)^{1/2}$  and  $\phi$  is the angle between the  $s_x$  axis and the vector  $(s_x, s_y)$ :

$$\mathbf{E}(\mathbf{r}', t) = \frac{1}{2\pi c} \int_{\phi=0}^{\pi} d\phi \int_{s=-\sin \theta_{\text{ill}}}^{\sin \theta_{\text{ill}}} \frac{s ds}{\sqrt{1-s^2}} \hat{\mathbf{a}}(s, \phi) \dot{E}^\infty(s, \phi, t - n_2 \hat{\mathbf{s}} \cdot \mathbf{r}' / c) \quad (13)$$

Note that the limits for the usual radial coordinates are modified such that  $s$  ranges from  $-\sin \theta_{\text{ill}}$  to  $\sin \theta_{\text{ill}}$ , and  $\phi$  ranges from 0 to  $\pi$ . In this way, the integral over the unit disk is transformed into an integral over the rectangular region  $\{|s| < \sin \theta_{\text{ill}}, 0 < \phi < \pi\}$  [16]. The integral over  $s$  can be approximated using Gauss-Legendre quadrature [21]. The  $\phi$  integral can be approximated trivially by the midpoint rule, since the integrand becomes periodic with period  $\pi$  once the  $s$  dependence is integrated out. For periodic functions, the midpoint rule is similar to the Gauss-Legendre quadrature in terms of accuracy [21]. In the following, we will denote this two-dimensional cubature rule by the acronym **GL**. An example **GL** quadrature rule with  $20 \times 8 = 160$  total points is shown in Fig. 2(b).

### 3.3. Custom cubature rules

There are more sophisticated alternatives to the approaches in the previous subsections for approximating two-dimensional integrals over special two-dimensional domains. A good review of the known rules tailored for the unit disk can be found in [16]. These rules require fewer cubature points than the **EQ** and **GL** rules for the same level of accuracy; thus reducing the number of plane waves in Eq. (8). The downside of these rules is that they have limited availability, with no readily available software for computing them. One has to resort to tabulated values for the positions and weights for the cubature points, such as R. Cools' online encyclopedia of cubature formulas [22]. For demonstrating the qualities of these specialized cubature formulas, we have considered the 127-point quadrature rule of degree 25. The degree  $d$  of a quadrature rule is the maximum total degree of the two-dimensional polynomials for which the cubature formula is exact. In the following, we will label the results obtained using this cubature rule by the acronym **CC**. The positions and weights for the 127-point quadrature are shown in Fig. 2(c).

It should be pointed out that the cubature rules in Fig. 2 are given for the standard unit disk  $s_x^2 + s_y^2 < 1$ . Since the integration domain in Eq. (3) is  $s_x^2 + s_y^2 < \sin^2 \theta_{\text{ill}}$ , the coordinates of the cubature points in Fig. 2 should be multiplied by  $\sin \theta_{\text{ill}}$ , and the weights by  $\sin^2 \theta_{\text{ill}}$ . In the following, we will present an error analysis for the cubature rules shown in Fig. 2.

#### 4. Error analysis

In order to perform an error analysis, the theoretical electric field  $E_{x_{\text{th}}}(\mathbf{r}', t)$  around the focus should be computed to a high degree of accuracy. For this purpose, we use previous results from Novotny & Hecht [12, Eq. (3.66)–(3.68)], except a sign change [23] and an extra  $\sqrt{2}$  factor for the (1,0) and (0,1) modes due to a difference between their definitions and ours. Suppressing the harmonic time dependence  $\exp(-i\omega t)$ ,  $E_{x_{\text{th}}}(\rho, \phi, z, t)$  is given by

$$E_{x_{\text{th}}}(\rho, \phi, z) = \frac{-ikf}{2} \sqrt{\frac{n_1}{n_2}} (I_{00} + I_{02} \cos 2\phi) \quad [(0,0) \text{ mode}] \quad (14)$$

$$E_{x_{\text{th}}}(\rho, \phi, z) = \frac{-ikf^2}{\sqrt{2}w_0} \sqrt{\frac{n_1}{n_2}} (iI_{11} \cos \phi + iI_{14} \cos 3\phi) \quad [(1,0) \text{ mode}] \quad (15)$$

$$E_{x_{\text{th}}}(\rho, \phi, z) = \frac{-ikf^2}{\sqrt{2}w_0} \sqrt{\frac{n_1}{n_2}} (i(I_{11} + 2I_{12}) \sin \phi + iI_{14} \sin 3\phi) \quad [(0,1) \text{ mode}] \quad (16)$$

in which  $E_{x_{\text{th}}}(\mathbf{r}')$  is expressed in cylindrical coordinates  $(\rho, \phi, z)$ . The  $\rho$  and  $z$  dependencies are contained entirely in the functions  $I_{00}$ ,  $I_{02}$ ,  $I_{11}$ ,  $I_{12}$ , and  $I_{14}$ ; which are given by [12]

$$I_{00}(\rho, z) = \int_0^{\theta_{\text{ill}}} e^{-\frac{1}{f_0^2} \frac{\sin^2 \theta}{\sin^2 \theta_{\text{ill}}}} \cos^{\frac{1}{2}} \theta \sin \theta (1 + \cos \theta) J_0(k\rho \sin \theta) e^{ikz \cos \theta} d\theta \quad (17)$$

$$I_{02}(\rho, z) = \int_0^{\theta_{\text{ill}}} e^{-\frac{1}{f_0^2} \frac{\sin^2 \theta}{\sin^2 \theta_{\text{ill}}}} \cos^{\frac{1}{2}} \theta \sin \theta (1 - \cos \theta) J_2(k\rho \sin \theta) e^{ikz \cos \theta} d\theta \quad (18)$$

$$I_{11}(\rho, z) = \int_0^{\theta_{\text{ill}}} e^{-\frac{1}{f_0^2} \frac{\sin^2 \theta}{\sin^2 \theta_{\text{ill}}}} \cos^{\frac{1}{2}} \theta \sin^2 \theta (1 + 3 \cos \theta) J_1(k\rho \sin \theta) e^{ikz \cos \theta} d\theta \quad (19)$$

$$I_{12}(\rho, z) = \int_0^{\theta_{\text{ill}}} e^{-\frac{1}{f_0^2} \frac{\sin^2 \theta}{\sin^2 \theta_{\text{ill}}}} \cos^{\frac{1}{2}} \theta \sin^2 \theta (1 - \cos \theta) J_1(k\rho \sin \theta) e^{ikz \cos \theta} d\theta \quad (20)$$

$$I_{14}(\rho, z) = \int_0^{\theta_{\text{ill}}} e^{-\frac{1}{f_0^2} \frac{\sin^2 \theta}{\sin^2 \theta_{\text{ill}}}} \cos^{\frac{1}{2}} \theta \sin^2 \theta (1 - \cos \theta) J_3(k\rho \sin \theta) e^{ikz \cos \theta} d\theta. \quad (21)$$

Here,  $J_n(\cdot)$  is the  $n^{\text{th}}$  order Bessel function. For the error analysis, these integrals are evaluated with very high accuracy using an adaptive Gauss-Kronrod quadrature rule. A general time dependence in  $\psi(t)$  is handled by multiplying Eqs. (14)–(16) by the temporal spectrum of  $\psi(t)$ , and taking the inverse temporal Fourier transform.

The error in the approximation in Eq. (8) can be quantified in various ways. Here, we consider two measures of error that quantify the difference between the computed focused beam and the theoretical focused beam over a surface  $A$ , such as the one shown in Fig. 3:

$$\varepsilon_2 = \frac{\left( \int dt \iint_A d\mathbf{r}' |\tilde{E}_x(\mathbf{r}', t) - E_{x_{\text{th}}}(\mathbf{r}', t)|^2 \right)^{1/2}}{\left( \int dt \iint_A d\mathbf{r}' |E_{x_{\text{th}}}(\mathbf{r}', t)|^2 \right)^{1/2}} \quad (22)$$

$$\varepsilon_{\text{inf}} = \frac{\max_{A,t} |\tilde{E}_x(\mathbf{r}', t) - E_{x_{\text{th}}}(\mathbf{r}', t)|}{\max_{A,t} |E_{x_{\text{th}}}(\mathbf{r}', t)|} \quad (23)$$

where  $\mathbf{r}'$  is the position variable on the surface  $A$ . The normalized Euclidean-norm error  $\varepsilon_2$  is a measure of the root-mean-square (rms) average of the error on  $A$  compared to the rms average of the theoretical field  $E_{x_{\text{th}}}(\mathbf{r}', t)$  on the same surface. The normalized  $\infty$ -norm error  $\varepsilon_{\text{inf}}$  is a measure of the maximum error on  $A$  compared to the maximum amplitude of the theoretical field  $E_{x_{\text{th}}}(\mathbf{r}', t)$  on the same surface. We assume in the examples to follow that the incident beam

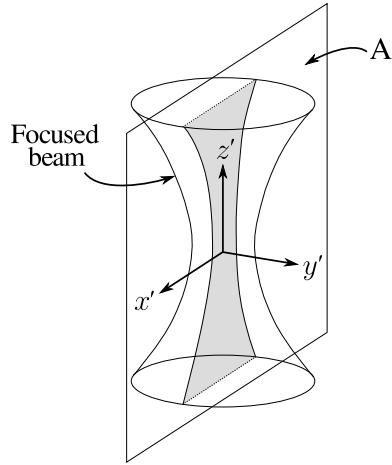


Fig. 3. An example surface  $A$  over which the computed and theoretical beams are compared. The error  $\varepsilon$  in Eq. (22) is calculated over this area.

is  $x$ -polarized [i.e.,  $\hat{\mathbf{e}}=\hat{\mathbf{x}}$  in Eq. (1)], and we only compare the dominant ( $\hat{\mathbf{x}}$ ) components  $\tilde{E}_x(\mathbf{r}',t)$  and  $E_{x_{\text{th}}}(\mathbf{r}',t)$  of the computed and theoretical electric fields. Our numerical experiments have shown that the comparison of the dominant components provides a very reliable estimate of the accuracy of the entire beam. Furthermore, we have found that the error calculated over any vertical plane of the beam (as long as the beam does not vanish on the plane, e.g., the  $yz$  plane for the  $(1,0)$  mode) is highly representative of the total error in the beam.

In our simulations, we considered an FDTD grid with the following parameters: grid spacing  $\Delta x = \Delta y = \Delta z = \Delta = 6.59$  nm,  $\Delta t = (0.98/\sqrt{3})\Delta/c$ , grid size  $1.713 \mu\text{m} \times 1.713 \mu\text{m} \times 3.295 \mu\text{m}$ , no absorbing boundary. The grid was filled with a lossless, non-dispersive, non-magnetic dielectric material representing immersion oil ( $n_2 = 1.518$ ). The focused laser beam was assumed to be  $x$ -polarized, and propagating in the  $+z$  direction. The aperture half angle  $\theta_{\text{ill}}$  was  $68.96^\circ$ , resulting in a numerical aperture of 1.4. The total-field/scattered-field (TF/SF) surface was located 5 cells away from the grid boundaries. The waveform  $\psi(t)$  of the paraxial beam incident on the entrance pupil of the focusing system [see Eq. (1)] was a modulated Gaussian function  $\psi(t) = \sin(2\pi f_0 t) \exp(-t^2/(2\tau^2))$  with  $\tau=3$  fs and  $f_0=5.889 \times 10^{14}$  Hz. This waveform has a Gaussian temporal spectrum that falls to 1% of its maximum amplitude (0.01% of its maximum power) at free-space wavelengths 400 nm and 700 nm. In order to reduce the errors caused by the inherent grid anisotropy and grid dispersion, the grid spacing was chosen to be  $1/40^{\text{th}}$  of the wavelength in the immersion oil at 400 nm. This is much stricter than the usual  $\lambda/20$ - $\lambda/15$  rule-of-thumb for the grid spacing. From Eqs. (14)–(21), it follows that the back focal length  $f$  of the lens is merely a constant scaling factor in all resulting field values, as long as the filling factor  $f_0$  is kept constant. We have used the somewhat arbitrary value of 0.1 m for the back focal length. The  $x$  component of the electric field is shown in Fig. 4 at several time instants for a filling factor of  $f_0 = 0.4$ . Figs. 4(a)–4(c) are for the  $(0,0)$ ,  $(1,0)$ , and  $(2,0)$  beams, respectively.

The surface  $A$  in Fig. 3 over which the error is calculated was the  $xz$  plane. We recorded the  $x$  component of the electric field in the FDTD grid over a rectangular grid on the  $xz$  plane, with a spacing of 12 cells in the  $z$  dimension and 8 cells in the  $x$  dimension. This amounts to a total of 1271 recording points. The normalized errors in Eqs. (22)–(23) were then approximated as a sum over these recording points. The results for a range of filling factors [see Eq. (7)] and for **EQ**, **GL**, and **CC** cubature rules are tabulated in Table 1 and Table 2. Table 1 is for the normalized Euclidean-norm error  $\varepsilon_2$ , while Table 2 is for the normalized  $\infty$ -norm error  $\varepsilon_{\infty}$ .

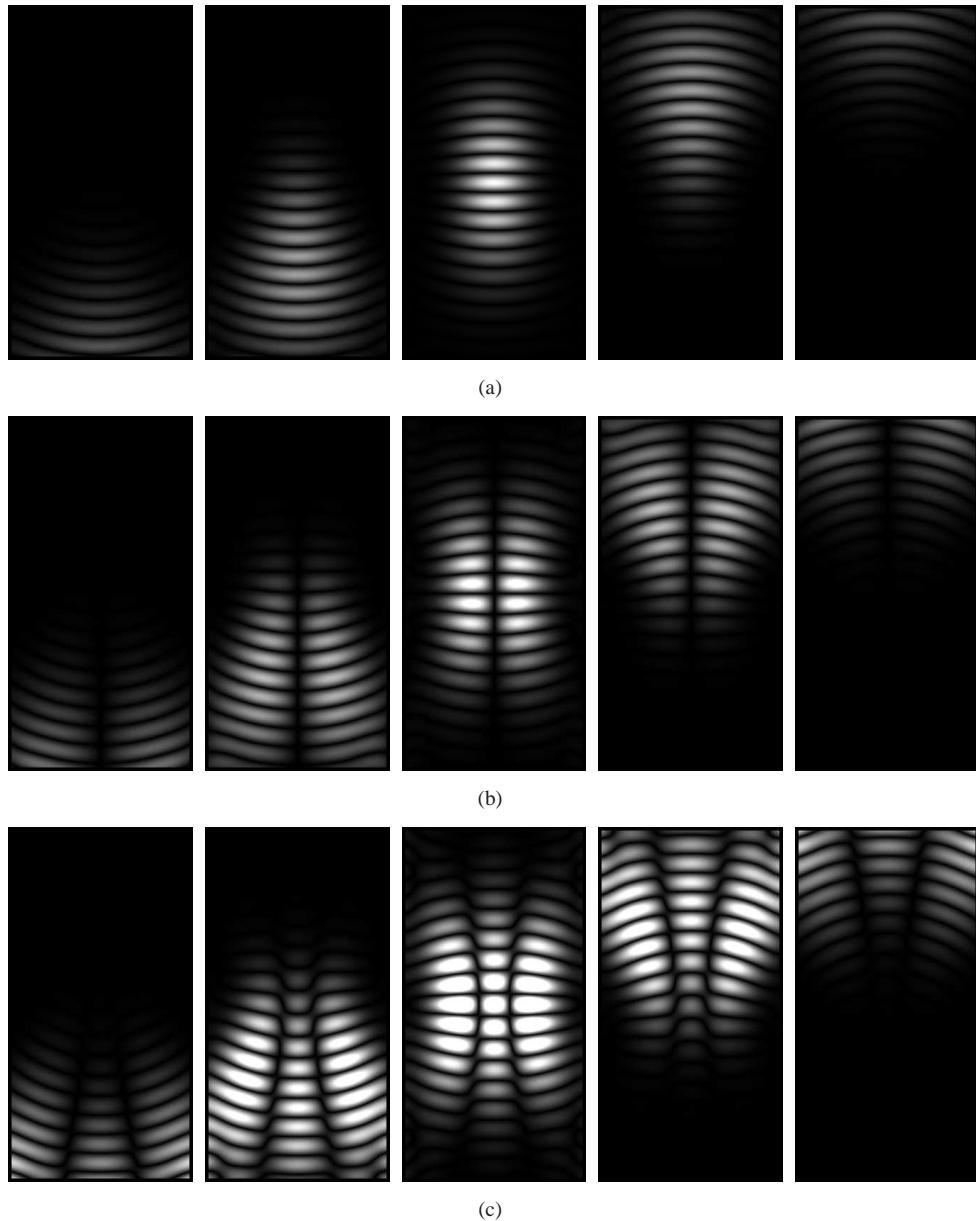


Fig. 4. Snapshots of the electric field amplitude from FDTD simulations for focused laser beams traveling in the  $+z$  direction. The  $x$  component of the electric field on the  $xz$  plane is plotted linearly in grayscale at 4.975 fs intervals from left to right. The maximum brightness corresponds to  $1.059 \times 10^5$  V/m. (a)  $(0,0)$  mode. [Media 1] (b)  $(1,0)$  mode. [Media 2] (c)  $(2,0)$  mode. [Media 3]

The positions and weights of the cubature points are shown in Fig. 2. The **EQ** rule has the best performance for small  $f_0$  values, while this performance deteriorates much faster than **GL** and **CC** as  $f_0$  increases. The normalized errors are generally higher for the  $(1,0)$  mode, with the exception of the Euclidean error  $\varepsilon_2$  for the **GL** rule. The **GL** rule is also seen to have superior performance for high  $f_0$ . The overall performance of the **CC** rule is particularly noteworthy. Although it has 30%-40% less number of points than the **EQ** and **GL** rules, it results in comparable error for the  $(0,0)$  mode. On the negative side, the performance of the **CC** rule deteriorates much faster than the others as the focal fields are evaluated farther away from the focus. Controlling the lateral dimensions of the TF/SF boundary is therefore much more important for the **CC** rule. The normalized  $\infty$ -norm error  $\varepsilon_{\text{inf}}$  resulting from the **CC** rule is also significantly higher for the  $(1,0)$  mode. A quick comparison of Table 1 and Table 2 shows that the two measures of error in Eqs. (22) and (23) are not drastically different from each other. One notable exception is the significantly increased error in the rightmost column in Table 2. The contribution to this error comes mainly from the corners of the measurement plane, as seen in Fig. 5(b). Although not shown here, it was observed that the error is distributed in a similar way regardless of the cubature rule employed. This reaffirms the importance of the limits of the TF/SF boundary in the approximation in Eq. (8).

Table 1. Normalized Euclidean-norm error  $\varepsilon_2$  [given by Eq. (22)] over the  $xz$  plane for the approximation in Eq. (8).

$f_0$	Cubature rules					
	Equally-spaced $s_x, s_y$ ( <b>EQ</b> )		20×8 Gauss-Legendre ( <b>GL</b> )		127-point cubature ( <b>CC</b> )	
	(0,0) mode	(1,0) mode	(0,0) mode	(1,0) mode	(0,0) mode	(1,0) mode
0.4	0.96%	1.07%	3.72%	0.92%	1.62%	3.70%
0.5	1.58%	2.83%	3.01%	1.16%	1.89%	4.02%
0.6	3.38%	5.78%	2.68%	1.86%	2.88%	5.30%

Table 2. Normalized  $\infty$ -norm error  $\varepsilon_{\text{inf}}$  [given by Eq. (23)] over the  $xz$  plane for the approximation in Eq. (8).

$f_0$	Cubature rules					
	Equally-spaced $s_x, s_y$ ( <b>EQ</b> )		20×8 Gauss-Legendre ( <b>GL</b> )		127-point cubature ( <b>CC</b> )	
	(0,0) mode	(1,0) mode	(0,0) mode	(1,0) mode	(0,0) mode	(1,0) mode
0.4	0.91%	1.32%	2.04%	0.83%	3.37%	9.64%
0.5	1.35%	3.17%	1.51%	1.80%	2.80%	7.24%
0.6	2.65%	5.27%	1.73%	3.02%	3.99%	6.90%

It was mentioned above that the grid spacing was chosen to be  $1/40^{\text{th}}$  of the wavelength in the immersion oil at 400 nm, which is much stricter than usual. Normally, a grid spacing of  $\approx \lambda/20$  would be enough for most purposes [1]. As the grid spacing is made larger, inherent FDTD errors caused by grid anisotropy and grid dispersion become more prominent. These effects are demonstrated in Table 3, in which the normalized Euclidean-norm error (Eq. (22)) is shown for

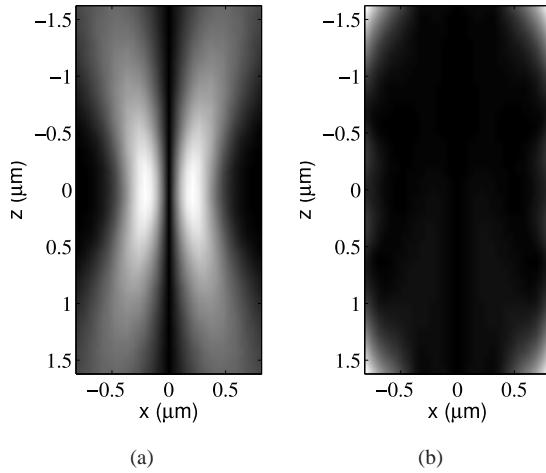


Fig. 5. The distribution of the error on the measurement ( $xz$ ) plane for the FDTD parameters in the rightmost column of Table 2. (a) The  $\infty$ -norm of the theoretical incident field. (b) The  $\infty$ -norm of the error. The grayscale upper limit is  $1/10^{\text{th}}$  of that in (a) for accentuation. The error is seen to be concentrated at the corners of the plane.

Table 3. The normalized Euclidean-norm error (Eq. (22)) for different grid spacings. The middle and right columns show the error with and without dispersion correction, respectively.

Grid spacing	Dispersion correction	No dispersion correction
$\lambda/40$	0.96%	1.93%
$\lambda/30$	1.68%	3.43%
$\lambda/20$	3.77%	7.75%
$\lambda/10$	15.2%	31.2%

grid spacings ranging from  $\lambda/40$  to  $\lambda/10$ . The wavelength  $\lambda$  is taken to be 400 nm, which is the lower  $-40$ -dB wavelength of the excitation waveform in the immersion oil. Each of the plane waves in Eq. (8) suffer from grid anisotropy and dispersion while propagating from the TF/SF surface toward the center of the grid. If no correction is applied to these plane waves, the errors increase significantly, as seen in the right column of Table 3. In our FDTD implementation (see Section 7), we have used a dispersion-correction algorithm called the matched-numerical-dispersion method [6]. The middle column in Table 3 shows that the error is drastically reduced by this dispersion correction algorithm.

The FDTD simulations were run in parallel on 96 processors on the *Quest* system (see Acknowledgments). The TF/SF focused beam calculations accounted for 77%, 75%, and 70% of the total simulation times for the **EQ**, **GL**, and **CC** rules, respectively. The additional memory requirements for the focused beams in our FDTD simulations were not significant, thanks to the low storage requirements of TF/SF sources. Because of the low spatial step ( $\lambda/40$ ) used, the simulations took much longer than necessary (7–10 minutes). At  $\lambda/20$ , the simulation took about 3 minutes on the same number of processors.

## 5. Inhomogeneous spaces

Until now, the focused laser beams were computed in homogeneous media. It would be of interest to observe the behavior of the beam when injected into an inhomogeneous medium; considering that almost any simulation will involve some inhomogeneity from which the beam will scatter. We will first consider a planar stratified medium with two layers, and then introduce a scatterer inside one of the layers. We will also show the synthetic microscope images of the scatterer in the latter case.

### 5.1. Two-layered space

If the beam is incident on an interface between two media, and the beam width is much smaller than the radius of curvature of the interface, the two media can be approximated as infinite half spaces. In our FDTD implementation (see Section 7), a plane wave can be simulated in the presence of arbitrary layered media [24]. Since the focused beam is constructed as a finite combination of plane waves, it can also be injected into layered spaces. As an example, we repeat the simulation for the  $(0,0)$  beam described in Section 4, except the following changes: The lower half space from which the beam is incident is air instead of immersion oil, and the upper half space has a refractive index of 1.5, which could represent glass or resin. The evolution of the electric field is shown in several time instants in Fig. 6. The reflection from the planar interface is seen clearly in the fourth snapshot. The beam is seen to be transmitted into the optically denser upper half space with a smaller wavelength. The TF/SF boundary was deliberately made narrower, to show more clearly the containment of the beam in both half spaces. The absence of leakage outside the TF/SF boundary indicates the accuracy of the plane-wave injection algorithm in the two-layered space.

### 5.2. Numerical microscope image of a scatterer

The complexity of the incidence geometry can be further increased by inserting scatterers inside the TF/SF boundary. The scattered electromagnetic field can then be collected outside the TF/SF boundary (e.g. using a near-field-to-far-field transform for multilayered spaces [25]) and processed suitably to yield a wealth of information. In this subsection, we will numerically calculate the microscope image of a scatterer under focused-beam illumination. This could represent one of the scanning positions in a confocal microscopy scenario, wherein a focused beam is scanned over the sample to obtain a complete image. The physical and FDTD parameters of the simulation are the same as those in Section 5.1, except the following changes: Two rectangular blocks of refractive index 1.38 and dimensions  $150\text{ nm} \times 600\text{ nm} \times 600\text{ nm}$  are buried symmetrically just above the material interface, and the grid is terminated by a 5-cell thick convolution perfectly-matched layer to absorb the scattered field [26]. The electric field at different time instants is shown in Fig. 7. Using the scattered field outside the TF/SF boundary, and propagating it to the far (Fraunhofer) zone using a multilayer NFFT [25], a numerical microscope image of the scatterer can be synthesized [27]. In Fig. 8(a), the cross section of the scatterers is shown at  $z = 300\text{ nm}$ . In Figs. 8(b)–8(c), two microscope images of the scatterers are shown under different microscope modalities. Both images are synthesized at wavelength  $\lambda = 509\text{ nm}$  using the light scattered into the lower half space, which amounts to epi (or reflectance) microscopy. The bright-field microscope image, shown in Fig. 8(b), is obtained by integrating the reflectance spectrum at each pixel over the excitation spectrum. The image is saturated because the grayscale limits are chosen to be the same as in Fig. 8(c), which shows the image obtained when the reflection from the planar interface is removed, leaving only the reflection from the scatterers. This is closely analogous to the procedure followed in dark-field microscopy. As a result of the weak scattering from the two blocks, the image in Fig. 8(c) is

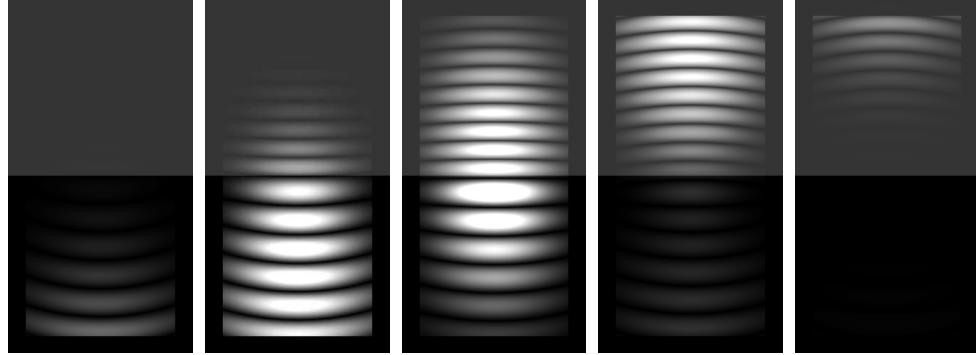


Fig. 6. Snapshots of the electric field amplitude for a focused laser beam traveling in the  $+z$  direction in a two-layered space. The  $x$  component of the electric field on the  $xz$  plane is plotted linearly in grayscale at 4.975 fs intervals from left to right. The maximum brightness corresponds to  $5 \times 10^4$  V/m. [Media 4]

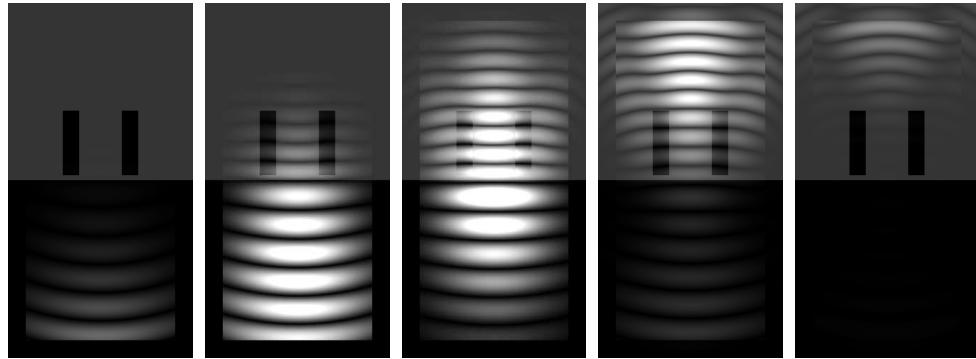


Fig. 7. Snapshots of the electric field amplitude for a focused laser beam traveling in the  $+z$  direction in a two-layered space containing rectangular scatterers. The  $x$  component of the electric field on the  $xz$  plane is plotted linearly in grayscale at 4.975 fs intervals from left to right. The maximum brightness corresponds to  $5 \times 10^4$  V/m. [Media 5]

much dimmer than the total bright-field image in Fig. 8(b). The overlap of the images of the two blocks is a consequence of the diffraction limit at  $\lambda = 509$  nm.

## 6. Future work

The error analysis presented here is by no means exhaustive. It is only meant to demonstrate the proof-of-concept for the viability of the plane-wave summation method explained in Section 3. Many improvements and innovations could be the subject of future work. For example, reliable guidelines for choosing the number of cubature points for the **GL** and **CC** rules for an arbitrary FDTD setting would be very useful. One could also seek alternatives to expressing the Debye-Wolf diffraction integral in Eq. (3) as a fixed sum of plane waves as in Eq. (8). Any method of computing Eq. (3) efficiently and accurately on the TF/SF boundary for an arbitrary  $\psi(t)$  in Eq. (1) could be a good alternative to the method described in this paper. The computational cost of such a method would still be inherently proportional to the surface area of the TF/SF boundary, rather than its volume.

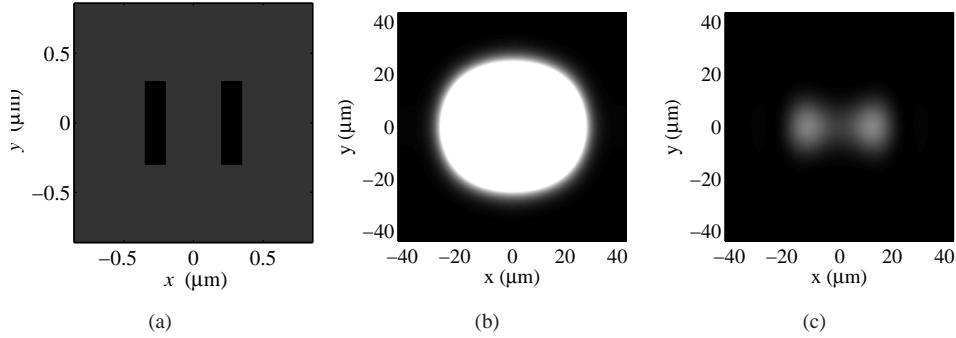


Fig. 8. Numerical microscope images of two rectangular scatterers buried inside the upper half space, under focused-beam illumination. (a) Refractive index map of the  $xy$  cross section at  $z = 300$  nm. (b) The bright-field image of the structure, dominated by the light reflected from the interface. (c) The image with the reflection from the interface removed. This resembles the procedure followed in dark-field microscopy.

## 7. FDTD implementation: *Angora*

The focused-beam creation method described in this paper has been incorporated into our free, open-source FDTD software, *Angora* [28,29]. *Angora* is currently available for the GNU/Linux operating system. It supports full parallelization in all three dimensions, allowing it to be run easily on high-performance computing systems. *Angora* operates by reading a text-based configuration file that specifies all details of the simulation. The *Angora* binaries and configuration files used to generate the results in this paper can be found on the *Angora* website [30]. Please consult the README file in that directory for details.

## 8. Summary

In this paper, we described a method to synthesize a laser beam focused tightly into a focal area by an aplanatic converging optical system. The synthesis method is especially geared toward the finite-difference time-domain (FDTD) method. We expressed the focused beam as an infinite summation of plane waves, and used a finite combination of them to approximate the beam. This approach has the advantage that the plane-wave creation methods in FDTD are well researched and documented. For our implementation, we chose the total-field/scattered-field (TF/SF) method for creating a plane wave [1]. We discussed three different methods for approximating the beam as a finite sum of plane waves, and presented a comparative error analysis for these methods. We showed that good accuracy can be obtained with acceptable computational cost. We investigated the behavior of the focused beam in a two-layered space, and computed the numerical microscope images of weakly-scattering objects under focused-beam illumination. We also discussed possibilities for future improvement. Finally, we introduced our free, open-source FDTD software (*Angora*), which features the method described in this paper. The binaries and configuration files used for the examples in this paper have been made available on the *Angora* website [30].

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